



LOW VOLTAGE CMOS 64K ELECTRICALLY ERASABLE PROGRAMMABLE ROM 8K X 8 BIT EEPROM

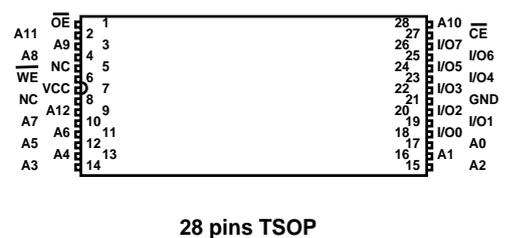
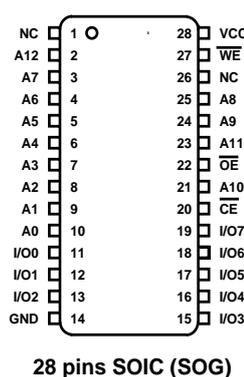
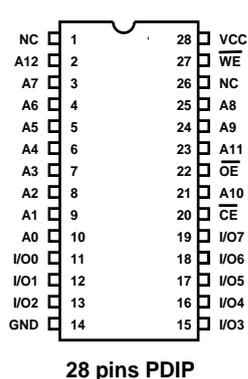
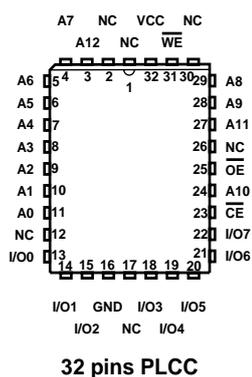
FEATURES:

- 200 ns Access Time
- Automatic Page Write Operation
 - Internal Control Timer
 - Internal Data and Address Latches for 64 Bytes
- Fast Write Cycle Times
 - Byte or Page Write Cycles: 10 ms
 - Time to Rewrite Complete Memory: 1.25 sec
 - Typical Byte Write Cycle Time: 160 μ sec
- Software Data Protection
- Low Power Dissipation
 - 20 mA Active Current
 - 35 μ A CMOS Standby Current
- Direct Microprocessor End of Write Detection
 - Data Polling
- High Reliability CMOS Technology with Self Redundant EEPROM Cell
 - Endurance: 100,000 Cycles
 - Data Retention: 10 Years
- TTL and CMOS Compatible Inputs and Outputs
- Single 3.3 V \pm 10% Power Supply for Read and Programming Operations
- JEDEC Approved Byte-Write Pinout

DESCRIPTION:

The Turbo IC 28LV64 is a 8K X 8 EEPROM fabricated with Turbo's proprietary, high reliability, high performance CMOS technology. The 64K bits of memory are organized as 8K by 8 bits. The device offers access time of 200 ns with power dissipation below 66 mW.

The 28LV64 has a 64-bytes page write operation enabling the entire memory to be typically written in less than 1.25 seconds. During a write cycle, the address and 1 to 64 bytes of data are internally latched, freeing the address and data bus for other microprocessor operations. The programming process is automatically controlled by the device using an internal control timer. Data polling on one or all I/O can be used to detect the end of a programming cycle. In addition, the 28LV64 includes an user-optional software data write mode offering additional protection against unwanted (false) write. The device utilizes an error protected self redundant cell for extended data retention and endurance.



PIN DESCRIPTION

ADDRESSES (A0 - A12)

The Addresses are used to select an 8 bits memory location during a write or read operation.

OUTPUT ENABLE (\overline{OE})

The Output Enable input activates the output buffers during the read operations.

CHIP ENABLES (\overline{CE})

The Chip Enable input must be low to enable all read/write operation on the device. By setting \overline{CE} high, the device is disabled and the power consumption is extremely low with the standby current below 35 μ A.

WRITE ENABLE (\overline{WE})

The Write Enable input initiates the writing of data into the memory.

DATA INPUT/OUTPUT (I/O0-I/O7)

Data Input/Output pins are used to read data out of the memory or to write Data into the memory.



DEVICE OPERATION

READ:

The 28LV64 is accessed like a static RAM. Read operations are initiated by both \overline{CE} and \overline{OE} going low and terminated by either \overline{CE} or \overline{OE} returning high. The outputs are at the high impedance state whenever \overline{CE} or \overline{OE} returns high. The two line control architecture gives designers flexibility in preventing bus contention.

WRITE:

A write cycle is initiated when \overline{CE} and \overline{WE} are low and \overline{OE} is high. The address is latched internally on the falling edge of \overline{CE} or \overline{WE} whichever occurs last. The data is latched by the rising edge of \overline{CE} or \overline{WE} whichever occurs first. Once a byte write cycle has been started, the internal timer automatically generates the write sequence to the completion of the write operation.

PAGE WRITE OPERATION:

The page write operation of 28LV64 allows one to 64 bytes of data to be serially loaded into the device and then simultaneously written into memory during the internally generated write cycle. After the first byte has been loaded, successive bytes of data may be loaded until the full page of 64 bytes is loaded. Each new byte to be written must be loaded within 200 μ s of the previously loaded byte. The page address defined by the addresses A6-A12 is latched by the first \overline{CE} or \overline{WE} falling edge which initiates a writing cycle and they will stay latched until the completion of the page write. Any changes in the page addresses during the load-write cycle will not affect the initially latched page addresses. Addresses A0 - A5 are used to define which bytes will be loaded and written within the 64 bytes page. The bytes may be loaded in any order that is convenient to the user. The content of a loaded byte may be altered at any time during the loading cycle if the maximum allowed byte-load time (200 μ s) is not exceeded. Only loaded bytes within the page will be written; no rewriting will occur to the non-selected bytes in the page.

DATA POLLING:

The 28LV64 features \overline{DATA} POLLING to indicate the completion of a write cycle to the host system. During a byte or page write cycle, an attempted read of the last byte loaded into the page will result in the complement of the loaded byte on all outputs I/O0 - I/O7 (i.e. loaded data 01010110, read data 10101001). \overline{DATA} Polling feature may be used by an attempted read on one or more outputs (whatever is convenient for the system developer). Once the write cycle has been completed, true data is valid on all outputs and the next cycle may be started.

DATA PROTECTION:

The 28LV64 has three hardware features to protect the written content of the memory against inadvertent writes :

- a.) Vcc threshold detector: If Vcc is below 2.5 V, the write capabilities of the chip is inhibited for whatever input conditions.
- b.) Noise protection: A \overline{WE} , \overline{OE} , or \overline{CE} pulse less than 10 ns in width is not able to initiate a write cycle.
- c.) Write inhibit: Holding \overline{OE} at low, or \overline{CE} at high, or \overline{WE} at high inhibits the write cycle.

SOFTWARE WRITE PROTECTION:

The 28LV64 offers a software controlled data write protection feature. The device is delivered to the user with the software data write protection DISABLED; i.e. the device will go to the data write operation as long as Vcc exceeds 2.5 V and \overline{CE} , \overline{WE} , and \overline{OE} inputs are set at write mode levels. The 28LV64 can be automatically protected against an accidental write operation during power-up or power-down without any external circuitry by enabling the software data write protection features. This features is enabled after the first write cycle which includes the software algorithm. After this operation is done, the data write function of the device may be performed only if every page write cycle is preceded by the software algorithm. The device will maintain its software protect feature for the rest of its life unless that the software algorithm for disabling the protection is implemented.

SOFTWARE ALGORITHM:

The 28LV64 has an internal register for the software algorithm which enables the memory to provide the user with additional features:

a.) Software Write Protect Enable

A sequence of three dummy data writes to the memory will activate internal EEPROM fuses during the first page write cycle. These EEPROM fuses will reject any write attempts of new pages of data unless the three dummy data writes are repeated at the beginning of any page writes. The timing for the dummy data and addresses must be the same as for a normal write operation. A violation of the three steps write protect sequence in data or address timing and content will abort the procedure and reset the device to the starting point condition.

Note: After the three dummy data writes, at least one page load/write cycle must be performed. If no additional page data is added to the three dummy data writes, the software write protect will not be enabled until the next write, which will not be protected.

Table 1 shows the required procedure for enabling the software write protect:

| Step | Mode | Address A12-A0 | Data I/O 7-0 |
|------|------------|----------------|--------------|
| 1 | Page Write | 1555 Hex | AA Hex |
| 2 | Page Write | 0AAA Hex | 55 Hex |
| 3 | Page Write | 1555 Hex | A0 Hex |
| 4-67 | Page Write | Address | Data |

b.) Software Write Protect Disable

The software algorithm of 28LV64 includes a six steps sequence of dummy data writing to disable the software write protect feature described in a.). The six steps write sequence shown in Table 2 must be performed at the beginning of a page write cycle. A violation of the six steps write sequence in data or address timing and content will abort the procedure and reset the chip to the starting point condition. After a page write cycle including the six steps write sequence has been performed, the 28LV64 does not require the use of three dummy data writes described in a.) for the following page write cycle. The device is at the software write protect disabled state.

Note: After the six dummy data writes, at least one page load/write cycle must be performed. If no additional page data is added to the six dummy data writes, the software write protect disable will not be activated. Table 2 shows the required procedure for disabling the software write protect:

| step | Mode | Address A12-A0 | Data I/O 7-0 |
|------|------------|----------------|--------------|
| 1 | Page Write | 1555 Hex | AA Hex |
| 2 | Page Write | 0AAA Hex | 55 Hex |
| 3 | Page Write | 1555 Hex | 80 Hex |
| 4 | Page Write | 1555 Hex | AA Hex |
| 5 | Page Write | 0AAA Hex | 55 Hex |
| 6 | Page Write | 1555 Hex | 20 Hex |
| 7-70 | Page Write | Address | Data |

c.) Software Chip Clear

The software algorithm of 28LV64 includes a sequence of six steps dummy data writing to perform a chip clear operation. Table 3 shows the six steps write sequence to perform the software chip clear operation:

| Step | Mode | Address A12-A0 | Data I/O 7-0 |
|------|------------|----------------|--------------|
| 1 | Page Write | 1555 Hex | AA Hex |
| 2 | Page Write | 0AAA Hex | 55 Hex |
| 3 | Page Write | 1555 Hex | 80 Hex |
| 4 | Page Write | 1555 Hex | AA Hex |
| 5 | Page Write | 0AAA Hex | 55 Hex |
| 6 | Page Write | 1555 Hex | 10 Hex |

At the end of the six steps write sequence shown in Table 3, the device automatically activates its internal timer to control the chip



erase cycle; typically takes 20 msec. After a software chip clear operation has been completed, all 64K bit locations of memory show high level at read operation mode.

d.) Software Autoclear Disable Mode

This software algorithm disables the internal automatic clear before write cycle. Table 4 shows the six steps needed to perform the autoclear disable mode:

| Step | Mode | Address A12-A0 | Data I/O 7-0 |
|------|------------|----------------|--------------|
| 1 | Page Write | 1555 Hex | AA Hex |
| 2 | Page Write | 0AAA Hex | 55 Hex |
| 3 | Page Write | 1555 Hex | 80 Hex |
| 4 | Page Write | 1555 Hex | AA Hex |
| 5 | Page Write | 0AAA Hex | 55 Hex |
| 6 | Page Write | 1555 Hex | 40 Hex |
| 7-70 | Page Write | Address | Data |

Page write operation using the software autoclear disable mode will reduce programming time to typically 5 msec. The page write using software autoclear disable mode is usually used after a chip clear or a software chip clear operation. At the end of the six steps sequence, the autoclear before write is disabled and will stay that way unless a power-down occurs or the software autoclear enable procedure is initiated.

e.) Software Autoclear Enable Mode

Automatic page clear before page write can be restored to 28LV64 either by Vcc power-down or by software autoclear enable mode. Table 5 shows the six steps page write procedure needed to enable software autoclear mode:

| Step | Mode | Address A12-A0 | Data I/O 7-0 |
|------|------------|----------------|--------------|
| 1 | Page Write | 1555 Hex | AA Hex |
| 2 | Page Write | 0AAA Hex | 55 Hex |
| 3 | Page Write | 1555 Hex | 80 Hex |
| 4 | Page Write | 1555 Hex | AA Hex |
| 5 | Page Write | 0AAA Hex | 55 Hex |
| 6 | Page Write | 1555 Hex | 50 Hex |
| 7-70 | Page Write | Address | Data |

(C) = COMMERCIAL
(I) = INDUSTRIAL
(M) = MILITARY

D.C. CHARACTERISTICS

| Symbol | Parameter | Condition | Min | Max | Units |
|------------------|------------------------|---|------|--------------|---------------|
| Icc | Active Vcc Current | $\overline{CE}=\overline{OE}=V_{il}$; All I/O Open, Min Read or Write Cycle Time | 20 | 30 | (C) mA |
| | | | 50 | 50 | (M) mA |
| | | | 35 | 50 | (C) μ A |
| I _{sb1} | CMOS Standby Current | $\overline{CE}=V_{cc}-0.3$ V to $V_{cc}+1$ V | | | (I&M) μ A |
| | | | | | |
| I _{il} | Input Leakage Current | | | 1 | μ A |
| I _{ol} | Output Leakage Current | | | 10 | μ A |
| V _{il} | Input Low Voltage | | -0.1 | -0.6 | V |
| V _{ih} | Input High Voltage | | 1.8 | $V_{cc}+0.3$ | V |
| V _{ol} | Output Low Voltage | I _{ol} =1.6 mA | | 0.3 | V |
| V _{oh} | Output High Voltage | I _{oh} =-0.1 mA | 1.8 | | V |

ABSOLUTE MAXIMUM STRESS RANGES *

TEMPERATURE
Storage: -65° C to 150° C
Under Bias: -55° C to 125° C
ALL INPUT OR OUTPUT VOLTAGES with respect to V_{ss} +6 V to -0.3 V

*"Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

Temperature Range: Commercial: 0° C to 70° C
Industrial: -40° C to 85° C
Military: -55° C to 125° C

V_{cc} Supply Voltage: 3.3 V \pm 10%

Endurance: 100,000 Cycles/Byte (Typical)
Data Retention: 10 Years

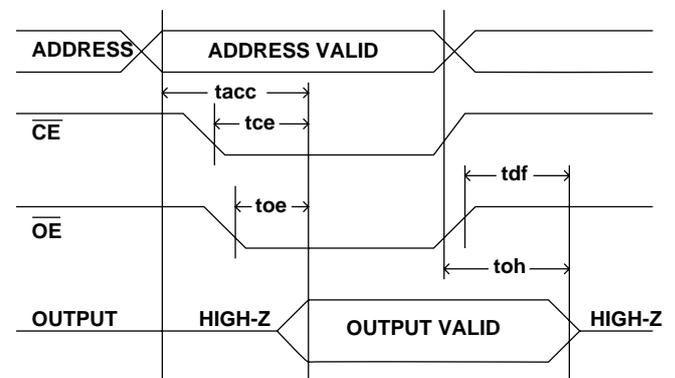
A.C. CHARACTERISTICS - READ OPERATION

| Symbol | Parameters | 28LV64-3 | | 28LV64-4 | | 28LV64-5 | | 28LV64-6 | | Unit |
|------------------|---|----------|-----|----------|-----|----------|-----|----------|-----|------|
| | | Min | Max | Min | Max | Min | Max | Min | Max | |
| t _{acc} | Address to Output Delay | 200 | | 250 | | 300 | | 400 | | ns |
| t _{ce} | \overline{CE} to Output Delay | 200 | | 250 | | 300 | | 400 | | ns |
| t _{oe} | \overline{OE} to Output | 110 | | 150 | | 150 | | 150 | | ns |
| t _{df} | \overline{OE} to Output In High Z | 0 | 90 | 0 | 90 | 0 | 90 | 0 | 90 | ns |
| t _{oh} | Output Hold from Address Changes, Chip Enable or Output Enable Whichever Occurs First | 0 | | 0 | | 0 | | 0 | | ns |

A.C. TEST CONDITIONS

Output Load : 1 TTL Load and Cl=100 pF
Input Rise and Fall Times : < 10 ns
Input Pulse Level : 0 V to 3 V
Timing Measurement Reference Level : 1.5 V

A.C. Read Wave Forms

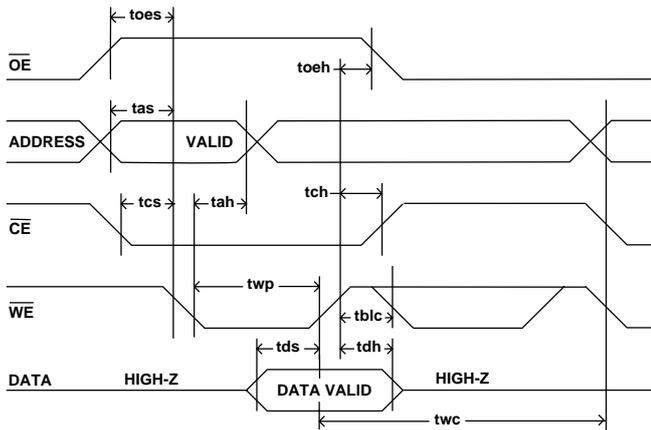




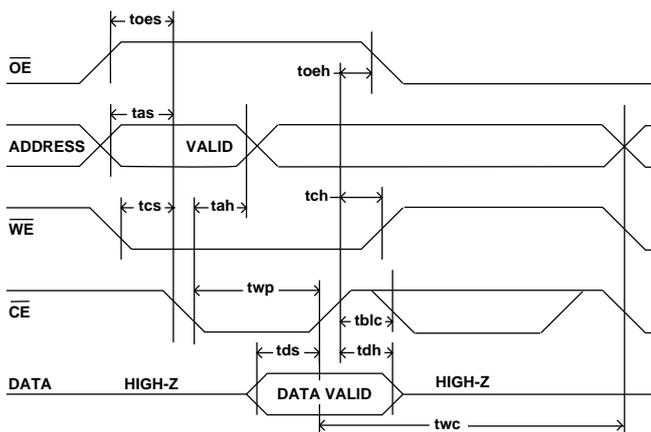
A.C. WRITE CHARACTERISTICS

| Symbol | Parameter | Min | Max | Units |
|--------|---|-----|-----|---------|
| tas | Address Set-up Time | 20 | | ns |
| tah | Address Hold Time | 100 | | ns |
| tcs | Write Set-up Time | 0 | | ns |
| tch | Write Hold Time | 0 | | ns |
| tcw | \overline{CE} Pulse Width | 150 | | ns |
| twp | \overline{WE} Pulse Width | 150 | | ns |
| toes | \overline{OE} Set-up Time | 20 | | ns |
| toeh | \overline{OE} Hold Time | 20 | | ns |
| tds | Data Set-up Time | 50 | | ns |
| tdh | Data Hold Time | 0 | | ns |
| tblc | Byte Load Cycle | 0.2 | 200 | μ s |
| tip | Last Byte Loaded to Data Polling Output | | 500 | μ s |
| twc | Write Cycle Time | | 10 | ms |
| twc | Write Cycle Time (IND & MIL) | | 15 | ms |

A.C. Write Characteristics \overline{WE} -Controlled



A.C. Write Characteristics \overline{CE} -Controlled



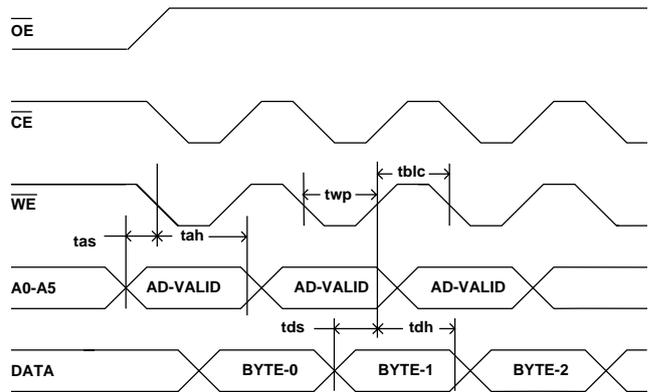
TURBO IC PRODUCTS AND DOCUMENTS

- All documents are subject to change without notice. Please contact Turbo IC for the latest revision of documents.
- Turbo IC does not assume any responsibility for any damage to the user that may result from accidents or operation under abnormal conditions.
- Turbo IC does not assume any responsibility for the use of any circuitry other than what embodied in a Turbo IC product. No other circuits, patents, licenses are implied.
- Turbo IC products are not authorized for use in life support systems or other critical systems where component failure may endanger life. System designers should design with error detection and correction, redundancy and back-up features.

PAGE MODE WRITE CHARACTERISTICS

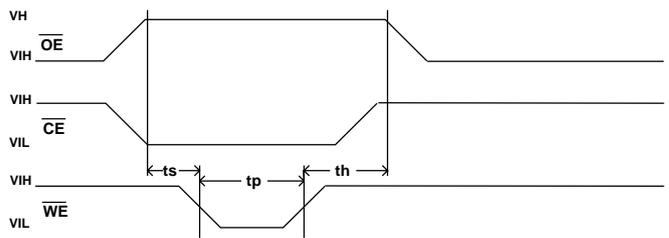
| Symbol | Parameter | Min | Max | Unit |
|--------|----------------------|-----|-----|---------|
| twc | Write Cycle Time | | 10 | ms |
| tas | Address Set-up Time | 20 | | ns |
| tah | Address Hold Time | 100 | | ns |
| tds | Data Set-up Time | 50 | | ns |
| tdh | Data Hold Time | 0 | | ns |
| twp | Write Pulse Width | 150 | | ns |
| tblc | Byte Load Cycle Time | 0.2 | 200 | μ s |

Page Mode Write Wave Form



Chip Clear Wave Form

The content of the 28LV64 may be altered to HIGH by the use of the Chip Clear operation. By setting \overline{CE} to low, \overline{OE} to 12 volts, and \overline{WE} to low, the entire memory can be cleared (written HIGH) within 20 ms. The Chip Clear operation is a latch operation mode. After the Chip Clear starts, the internal chip timer takes over and completes the clear without \overline{CE} , \overline{OE} and \overline{WE} being held active.



ts= 20 ns
tp= 200 ns
th= 20 ns
VH=12.0 V±0.5V

Part Numbers & Order Information

28LV64PC-4

| | | | |
|------------------|---------|---------------|-----------|
| 8K x 8 EEPROM | Package | Temperature | Speed |
| | J -PLCC | C -Commercial | -3 200 ns |
| | P -PDIP | I -Industrial | -4 250 ns |
| | S -SOIC | M -Military | -5 300 ns |
| | T -TSOP | | -6 400 ns |